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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Discontinued at Digi-Key
Core Processor	C166SV2
Core Size	16-Bit
Speed	66MHz
Connectivity	CANbus, EBI/EMI, I <sup>2</sup> C, LINbus, SPI, SSC, UART/USART, USI
Peripherals	I <sup>2</sup> S, POR, PWM, WDT
Number of I/O	75
Program Memory Size	192KB (192K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	24K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 11x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP Exposed Pad
Supplier Device Package	PG-LQFP-100-3
Purchase URL	<a href="https://www.e-xfl.com/product-detail/infineon-technologies/xe164g24f66lacfxqma1">https://www.e-xfl.com/product-detail/infineon-technologies/xe164g24f66lacfxqma1</a>

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## **Summary of Features**

- 2) Specific information about the on-chip Flash memory in [Table 2](#).
- 3) All derivatives additionally provide 1 Kbyte SBRAM, 2 Kbytes DPRAM, and 16 Kbytes DSRAM (12 Kbytes for devices with 192 Kbytes of Flash).
- 4) Specific information about the available channels in [Table 3](#).  
Analog input channels are listed for each Analog/Digital Converter module separately (ADC0 + ADC1).

**Table 4 Pin Definitions and Functions (cont'd)**

Pin	Symbol	Ctrl.	Type	Function
35	P5.15	I	In/A	<b>Bit 15 of Port 5, General Purpose Input</b>
	ADC0_CH15	I	In/A	<b>Analog Input Channel 15 for ADC0</b>
36	P2.12	O0 / I	St/B	<b>Bit 12 of Port 2, General Purpose Input/Output</b>
	U0C0_SELO4	O1	St/B	<b>USIC0 Channel 0 Select/Control 4 Output</b>
	U0C1_SELO3	O2	St/B	<b>USIC0 Channel 1 Select/Control 3 Output</b>
	READY	I	St/B	<b>External Bus Interface READY Input</b>
37	P2.11	O0 / I	St/B	<b>Bit 11 of Port 2, General Purpose Input/Output</b>
	U0C0_SELO2	O1	St/B	<b>USIC0 Channel 0 Select/Control 2 Output</b>
	U0C1_SELO2	O2	St/B	<b>USIC0 Channel 1 Select/Control 2 Output</b>
	$\overline{\text{BHE}}/\text{WRH}$	OH	St/B	<b>External Bus Interf. High-Byte Control Output</b> Can operate either as Byte High Enable ( $\overline{\text{BHE}}$ ) or as Write strobe for High Byte ( $\text{WRH}$ ).
39	P2.0	O0 / I	St/B	<b>Bit 0 of Port 2, General Purpose Input/Output</b>
	AD13	OH / I	St/B	<b>External Bus Interface Address/Data Line 13</b>
	RxDC0C	I	St/B	<b>CAN Node 0 Receive Data Input</b>
40	P2.1	O0 / I	St/B	<b>Bit 1 of Port 2, General Purpose Input/Output</b>
	TxDC0	O1	St/B	<b>CAN Node 0 Transmit Data Output</b>
	AD14	OH / I	St/B	<b>External Bus Interface Address/Data Line 14</b>
	ESR1_5	I	St/B	<b>ESR1 Trigger Input 5</b>
	EX0AINA	I	St/B	<b>External Interrupt Trigger Input</b>
41	P2.2	O0 / I	St/B	<b>Bit 2 of Port 2, General Purpose Input/Output</b>
	TxDC1	O1	St/B	<b>CAN Node 1 Transmit Data Output</b>
	AD15	OH / I	St/B	<b>External Bus Interface Address/Data Line 15</b>
	ESR2_5	I	St/B	<b>ESR2 Trigger Input 5</b>
	EX1AINA	I	St/B	<b>External Interrupt Trigger Input</b>
42	P4.0	O0 / I	St/B	<b>Bit 0 of Port 4, General Purpose Input/Output</b>
	CC2_24	O3 / I	St/B	<b>CAPCOM2 CC24IO Capture Inp./ Compare Out.</b>
	$\overline{\text{CS0}}$	OH	St/B	<b>External Bus Interface Chip Select 0 Output</b>

**Table 4 Pin Definitions and Functions (cont'd)**

<b>Pin</b>	<b>Symbol</b>	<b>Ctrl.</b>	<b>Type</b>	<b>Function</b>
89	P10.14	O0 / I	St/B	<b>Bit 14 of Port 10, General Purpose Input/Output</b>
	U1C0_SELO1	O1	St/B	<b>USIC1 Channel 0 Select/Control 1 Output</b>
	U0C1_DOUT	O2	St/B	<b>USIC0 Channel 1 Shift Data Output</b>
	$\overline{\text{RD}}$	OH	St/B	<b>External Bus Interface Read Strobe Output</b>
	ESR2_2	I	St/B	<b>ESR2 Trigger Input 2</b>
	U0C1_DX0C	I	St/B	<b>USIC0 Channel 1 Shift Data Input</b>
	RxDC3C	I	St/B	<b>CAN Node 3 Receive Data Input</b>
90	P1.4	O0 / I	St/B	<b>Bit 4 of Port 1, General Purpose Input/Output</b>
	CCU62_COUT61	O1	St/B	<b>CCU62 Channel 1 Output</b>
	U1C1_SELO4	O2	St/B	<b>USIC1 Channel 1 Select/Control 4 Output</b>
	U2C0_SELO5	O3	St/B	<b>USIC2 Channel 0 Select/Control 5 Output</b>
	A12	OH	St/B	<b>External Bus Interface Address Line 12</b>
	U2C0_DX2B	I	St/B	<b>USIC2 Channel 0 Shift Control Input</b>
91	P10.15	O0 / I	St/B	<b>Bit 15 of Port 10, General Purpose Input/Output</b>
	U1C0_SELO2	O1	St/B	<b>USIC1 Channel 0 Select/Control 2 Output</b>
	U0C1_DOUT	O2	St/B	<b>USIC0 Channel 1 Shift Data Output</b>
	U1C0_DOUT	O3	St/B	<b>USIC1 Channel 0 Shift Data Output</b>
	ALE	OH	St/B	<b>External Bus Interf. Addr. Latch Enable Output</b>
	U0C1_DX1C	I	St/B	<b>USIC0 Channel 1 Shift Clock Input</b>
92	P1.5	O0 / I	St/B	<b>Bit 5 of Port 1, General Purpose Input/Output</b>
	CCU62_COUT60	O1	St/B	<b>CCU62 Channel 0 Output</b>
	U1C1_SELO3	O2	St/B	<b>USIC1 Channel 1 Select/Control 3 Output</b>
	$\overline{\text{BRKOUT}}$	O3	St/B	<b>OCDS Break Signal Output</b>
	A13	OH	St/B	<b>External Bus Interface Address Line 13</b>
	U2C0_DX0C	I	St/B	<b>USIC2 Channel 0 Shift Data Input</b>

**Functional Description**

With this hardware most XE164 instructions can be executed in a single machine cycle of 12.5 ns with an 80-MHz CPU clock. For example, shift and rotate instructions are always processed during one machine cycle, no matter how many bits are shifted. Also, multiplication and most MAC instructions execute in one cycle. All multiple-cycle instructions have been optimized so that they can be executed very fast; for example, a 32-/16-bit division is started within 4 cycles while the remaining cycles are executed in the background. Another pipeline optimization, the branch target prediction, eliminates the execution time of branch instructions if the prediction was correct.

The CPU has a register context consisting of up to three register banks with 16 word-wide GPRs each at its disposal. One of these register banks is physically allocated within the on-chip DPRAM area. A Context Pointer (CP) register determines the base address of the active register bank accessed by the CPU at any time. The number of these register bank copies is only restricted by the available internal RAM space. For easy parameter passing, a register bank may overlap others.

A system stack of up to 32 Kwords is provided for storage of temporary data. The system stack can be allocated to any location within the address space (preferably in the on-chip RAM area); it is accessed by the CPU with the stack pointer (SP) register. Two separate SFRs, STKOV and STKUN, are implicitly compared with the stack pointer value during each stack access to detect stack overflow or underflow.

The high performance of the CPU hardware implementation can be best utilized by the programmer with the highly efficient XE164 instruction set. This includes the following instruction classes:

- Standard Arithmetic Instructions
- DSP-Oriented Arithmetic Instructions
- Logical Instructions
- Boolean Bit Manipulation Instructions
- Compare and Loop Control Instructions
- Shift and Rotate Instructions
- Prioritize Instruction
- Data Movement Instructions
- System Stack Instructions
- Jump and Call Instructions
- Return Instructions
- System Control Instructions
- Miscellaneous Instructions

The basic instruction length is either 2 or 4 bytes. Possible operand types are bits, bytes and words. A variety of direct, indirect or immediate addressing modes are provided to specify the required operands.

## Functional Description

The XE164 includes an excellent mechanism to identify and process exceptions or error conditions that arise during run-time, the so-called 'Hardware Traps'. A hardware trap causes an immediate non-maskable system reaction similar to a standard interrupt service (branching to a dedicated vector table location). The occurrence of a hardware trap is also indicated by a single bit in the trap flag register (TFR). Unless another higher-priority trap service is in progress, a hardware trap will interrupt any ongoing program execution. In turn, hardware trap services can normally not be interrupted by standard or PEC interrupts.

**Table 7** shows all possible exceptions or error conditions that can arise during runtime:

**Table 7      Trap Summary**

Exception Condition	Trap Flag	Trap Vector	Vector Location <sup>1)</sup>	Trap Number	Trap Priority
Reset Functions	—	RESET	xx'0000 <sub>H</sub>	00 <sub>H</sub>	III
Class A Hardware Traps:					
• System Request 0	SR0	SR0TRAP	xx'0008 <sub>H</sub>	02 <sub>H</sub>	II
• Stack Overflow	STKOF	STOTRAP	xx'0010 <sub>H</sub>	04 <sub>H</sub>	II
• Stack Underflow	STKUF	STUTRAP	xx'0018 <sub>H</sub>	06 <sub>H</sub>	II
• Software Break	SOFTBRK	SBRKTRAP	xx'0020 <sub>H</sub>	08 <sub>H</sub>	II
Class B Hardware Traps:					
• System Request 1	SR1	BTRAP	xx'0028 <sub>H</sub>	0A <sub>H</sub>	I
• Undefined Opcode	UNDOPC	BTRAP	xx'0028 <sub>H</sub>	0A <sub>H</sub>	I
• Memory Access Error	ACER	BTRAP	xx'0028 <sub>H</sub>	0A <sub>H</sub>	I
• Protected Instruction Fault	PRTFLT	BTRAP	xx'0028 <sub>H</sub>	0A <sub>H</sub>	I
• Illegal Word Operand Access	ILLOPA	BTRAP	xx'0028 <sub>H</sub>	0A <sub>H</sub>	I
Reserved	—	—	[2C <sub>H</sub> - 3C <sub>H</sub> ]	[0B <sub>H</sub> - 0F <sub>H</sub> ]	—
Software Traps:	—	—	Any	Any	Current
• TRAP Instruction			[xx'0000 <sub>H</sub> - xx'01FC <sub>H</sub> ] in steps of 4 <sub>H</sub>	[00 <sub>H</sub> - 7F <sub>H</sub> ]	CPU Priority

1) Register VECSEG defines the segment where the vector table is located to.

Bitfield VECSC in register CPUCON1 defines the distance between two adjacent vectors. This table represents the default setting, with a distance of 4 (two words) between two vectors.



### **3.5 On-Chip Debug Support (OCDS)**

The On-Chip Debug Support system built into the XE164 provides a broad range of debug and emulation features. User software running on the XE164 can be debugged within the target system environment.

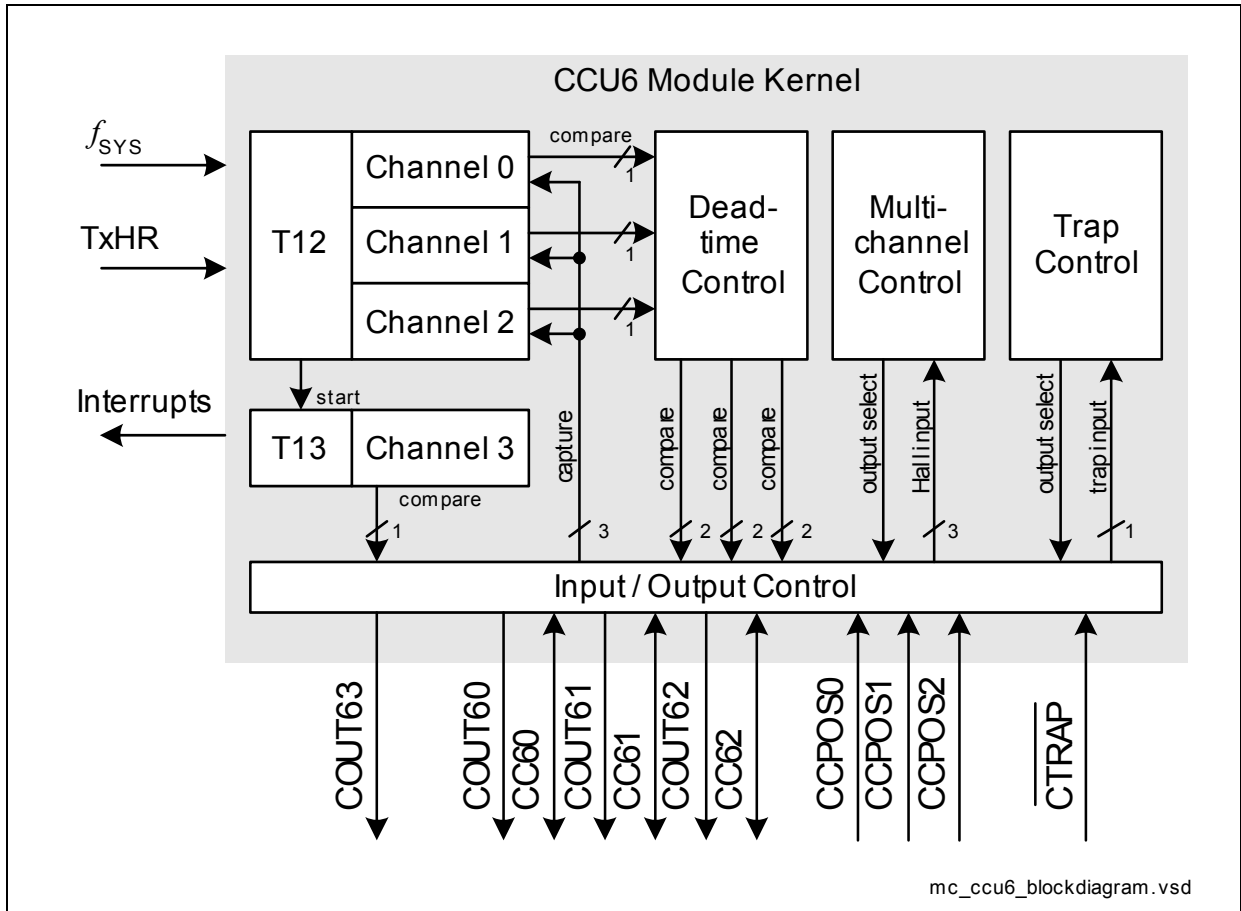
The OCDS is controlled by an external debugging device via the debug interface. This consists of the JTAG port conforming to IEEE-1149. The debug interface can be completed with an optional break interface.

The debugger controls the OCDS with a set of dedicated registers accessible via the debug interface (JTAG). In addition the OCDS system can be controlled by the CPU, e.g. by a monitor program. An injection interface allows the execution of OCDS-generated instructions by the CPU.

Multiple breakpoints can be triggered by on-chip hardware, by software, or by an external trigger input. Single stepping is supported, as is the injection of arbitrary instructions and read/write access to the complete internal address space. A breakpoint trigger can be answered with a CPU halt, a monitor call, a data transfer, or/and the activation of an external signal.

Tracing data can be obtained via the debug interface, or via the external bus interface for increased performance.

The JTAG interface uses four interface signals, to communicate with external circuitry. The debug interface can be amended with two optional break lines.



**Figure 6 CCU6 Block Diagram**

Timer T12 can work in capture and/or compare mode for its three channels. The modes can also be combined. Timer T13 can work in compare mode only. The multi-channel control unit generates output patterns that can be modulated by timer T12 and/or timer T13. The modulation sources can be selected and combined for signal modulation.

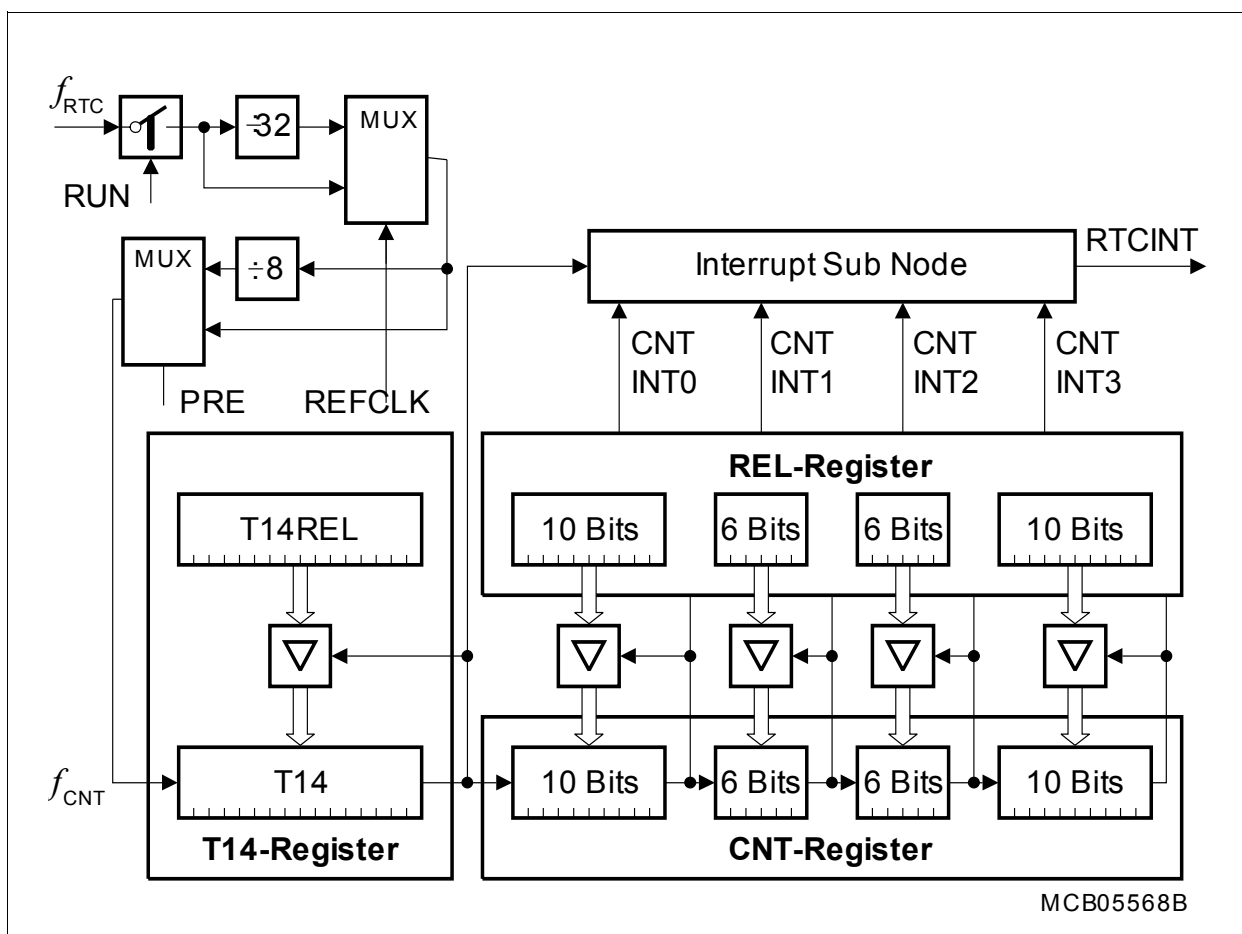
### 3.9 Real Time Clock

The Real Time Clock (RTC) module of the XE164 can be clocked with a clock signal selected from internal sources or external sources (pins).

The RTC basically consists of a chain of divider blocks:

- Selectable 32:1 and 8:1 dividers (on - off)
- The reloadable 16-bit timer T14
- The 32-bit RTC timer block (accessible via registers RTCH and RTCL) consisting of:
  - a reloadable 10-bit timer
  - a reloadable 6-bit timer
  - a reloadable 6-bit timer
  - a reloadable 10-bit timer

All timers count up. Each timer can generate an interrupt request. All requests are combined to a common node request.



**Figure 9 RTC Block Diagram**

*Note: The registers associated with the RTC are only affected by a power reset.*

### **MultiCAN Features**

- CAN functionality conforming to CAN specification V2.0 B active for each CAN node (compliant to ISO 11898)
- Up to four independent CAN nodes
- 128 independent message objects (shared by the CAN nodes)
- Dedicated control registers for each CAN node
- Data transfer rate up to 1 Mbit/s, individually programmable for each node
- Flexible and powerful message transfer control and error handling capabilities
- Full-CAN functionality for message objects:
  - Can be assigned to one of the CAN nodes
  - Configurable as transmit or receive objects, or as message buffer FIFO
  - Handle 11-bit or 29-bit identifiers with programmable acceptance mask for filtering
  - Remote Monitoring Mode, and frame counter for monitoring
- Automatic Gateway Mode support
- 16 individually programmable interrupt nodes
- Analyzer mode for CAN bus monitoring

**Functional Description**

**Table 10 Instruction Set Summary (cont'd)**

<b>Mnemonic</b>	<b>Description</b>	<b>Bytes</b>
ROL/ROR	Rotate left/right direct word GPR	2
ASHR	Arithmetic (sign bit) shift right direct word GPR	2
MOV(B)	Move word (byte) data	2 / 4
MOVBS/Z	Move byte operand to word op. with sign/zero extension	2 / 4
JMPA/I/R	Jump absolute/indirect/relative if condition is met	4
JMPS	Jump absolute to a code segment	4
JB(C)	Jump relative if direct bit is set (and clear bit)	4
JNB(S)	Jump relative if direct bit is not set (and set bit)	4
CALLA/I/R	Call absolute/indirect/relative subroutine if condition is met	4
CALLS	Call absolute subroutine in any code segment	4
PCALL	Push direct word register onto system stack and call absolute subroutine	4
TRAP	Call interrupt service routine via immediate trap number	2
PUSH/POP	Push/pop direct word register onto/from system stack	2
SCXT	Push direct word register onto system stack and update register with word operand	4
RET(P)	Return from intra-segment subroutine (and pop direct word register from system stack)	2
RETS	Return from inter-segment subroutine	2
RETI	Return from interrupt service subroutine	2
SBRK	Software Break	2
SRST	Software Reset	4
IDLE	Enter Idle Mode	4
PWRDN	Unused instruction <sup>1)</sup>	4
SRVWDT	Service Watchdog Timer	4
DISWDT/ENWDT	Disable/Enable Watchdog Timer	4
EINIT	End-of-Initialization Register Lock	4
ATOMIC	Begin ATOMIC sequence	2
EXTR	Begin EXTended Register sequence	2
EXTP(R)	Begin EXTended Page (and Register) sequence	2 / 4
EXTS(R)	Begin EXTended Segment (and Register) sequence	2 / 4

**Functional Description**

**Table 10      Instruction Set Summary (cont'd)**

<b>Mnemonic</b>	<b>Description</b>	<b>Bytes</b>
NOP	Null operation	2
CoMUL/CoMAC	Multiply (and accumulate)	4
CoADD/CoSUB	Add/Subtract	4
Co(A)SHR	(Arithmetic) Shift right	4
CoSHL	Shift left	4
CoLOAD/STORE	Load accumulator/Store MAC register	4
CoCMP	Compare	4
CoMAX/MIN	Maximum/Minimum	4
CoABS/CoRND	Absolute value/Round accumulator	4
CoMOV	Data move	4
CoNEG/NOP	Negate accumulator/Null operation	4

- 1) The Enter Power Down Mode instruction is not used in the XE164, due to the enhanced power control scheme. PWRDN will be correctly decoded, but will trigger no action.

#### 4.2.1 DC Parameters for Upper Voltage Area

These parameters apply to the upper IO voltage range,  $4.5\text{ V} \leq V_{DDP} \leq 5.5\text{ V}$ .

**Table 14 DC Characteristics for Upper Voltage Range**  
(Operating Conditions apply)<sup>1)</sup>

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input low voltage (all except XTAL1)	$V_{IL}$ SR	-0.3	–	$0.3 \times V_{DDP}$	V	–
Input high voltage (all except XTAL1)	$V_{IH}$ SR	$0.7 \times V_{DDP}$	–	$V_{DDP} + 0.3$	V	–
Input Hysteresis <sup>2)</sup>	HYS CC	$0.11 \times V_{DDP}$	–	–	V	$V_{DDP}$ in [V], Series resistance = $0\ \Omega$
Output low voltage	$V_{OL}$ CC	–	–	1.0	V	$I_{OL} \leq I_{OLmax}^{3)}$
Output low voltage	$V_{OL}$ CC	–	–	0.4	V	$I_{OL} \leq I_{OLnom}^{3)4)}$
Output high voltage <sup>5)</sup>	$V_{OH}$ CC	$V_{DDP} - 1.0$	–	–	V	$I_{OH} \geq I_{OHmax}^{3)}$
Output high voltage <sup>5)</sup>	$V_{OH}$ CC	$V_{DDP} - 0.4$	–	–	V	$I_{OH} \geq I_{OHnom}^{3)4)}$
Input leakage current (Port 5, Port 15) <sup>6)</sup>	$I_{OZ1}$ CC	–	$\pm 10$	$\pm 200$	nA	$0\text{ V} < V_{IN} < V_{DDP}$
Input leakage current (all other) <sup>6)7)</sup>	$I_{OZ2}$ CC	–	$\pm 0.2$	$\pm 5$	$\mu\text{A}$	$T_J \leq 110^\circ\text{C}$ , $0.45\text{ V} < V_{IN}$ $< V_{DDP}$
Pull level keep current	$I_{PLK}$	–	–	$\pm 30$	$\mu\text{A}$	$V_{PIN} \geq V_{IH}$ (up) <sup>8)</sup> $V_{PIN} \leq V_{IL}$ (dn)
Pull level force current	$I_{PLF}$	$\pm 250$	–	–	$\mu\text{A}$	$V_{PIN} \leq V_{IL}$ (up) <sup>8)</sup> $V_{PIN} \geq V_{IH}$ (dn)
Pin capacitance <sup>9)</sup> (digital inputs/outputs)	$C_{IO}$ CC	–	–	10	pF	

1) Keeping signal levels within the limits specified in this table ensures operation without overload conditions. For signal levels outside these specifications, also refer to the specification of the overload current  $I_{OV}$ .

2) Not subject to production test - verified by design/characterization. Hysteresis is implemented to avoid metastable states and switching due to internal ground bounce. It cannot suppress switching due to external system noise under all conditions.

3) The maximum deliverable output current of a port driver depends on the selected output driver mode, see [Table 13, Current Limits for Port Output Drivers](#). The limit for pin groups must be respected.

### 4.2.3 Power Consumption

The power consumed by the XE164 depends on several factors such as supply voltage, operating frequency, active circuits, and operating temperature. The power consumption specified here consists of two components:

- The switching current  $I_S$  depends on the device activity
- The leakage current  $I_{LK}$  depends on the device temperature

To determine the actual power consumption, always both components, switching current  $I_S$  ([Table 16](#)) and leakage current  $I_{LK}$  ([Table 17](#)) must be added:

$$I_{DDP} = I_S + I_{LK}.$$

*Note: The power consumption values are not subject to production test. They are verified by design/characterization.*

*To determine the total power consumption for dimensioning the external power supply, also the pad driver currents must be considered.*

The given power consumption parameters and their values refer to specific operating conditions:

- **Active mode:**  
Regular operation, i.e. peripherals are active, code execution out of Flash.
- **Stopover mode:**  
Crystal oscillator and PLL stopped, Flash switched off, clock in domain DMP\_1 stopped.

*Note: The maximum values cover the complete specified operating range of all manufactured devices.*

*The typical values refer to average devices under typical conditions, such as nominal supply voltage, room temperature, application-oriented activity.*

*After a power reset, the decoupling capacitors for  $V_{DDI}$  are charged with the maximum possible current, see parameter  $I_{CC}$  in [Table 20](#).*

For additional information, please refer to [Section 5.2, Thermal Considerations](#).

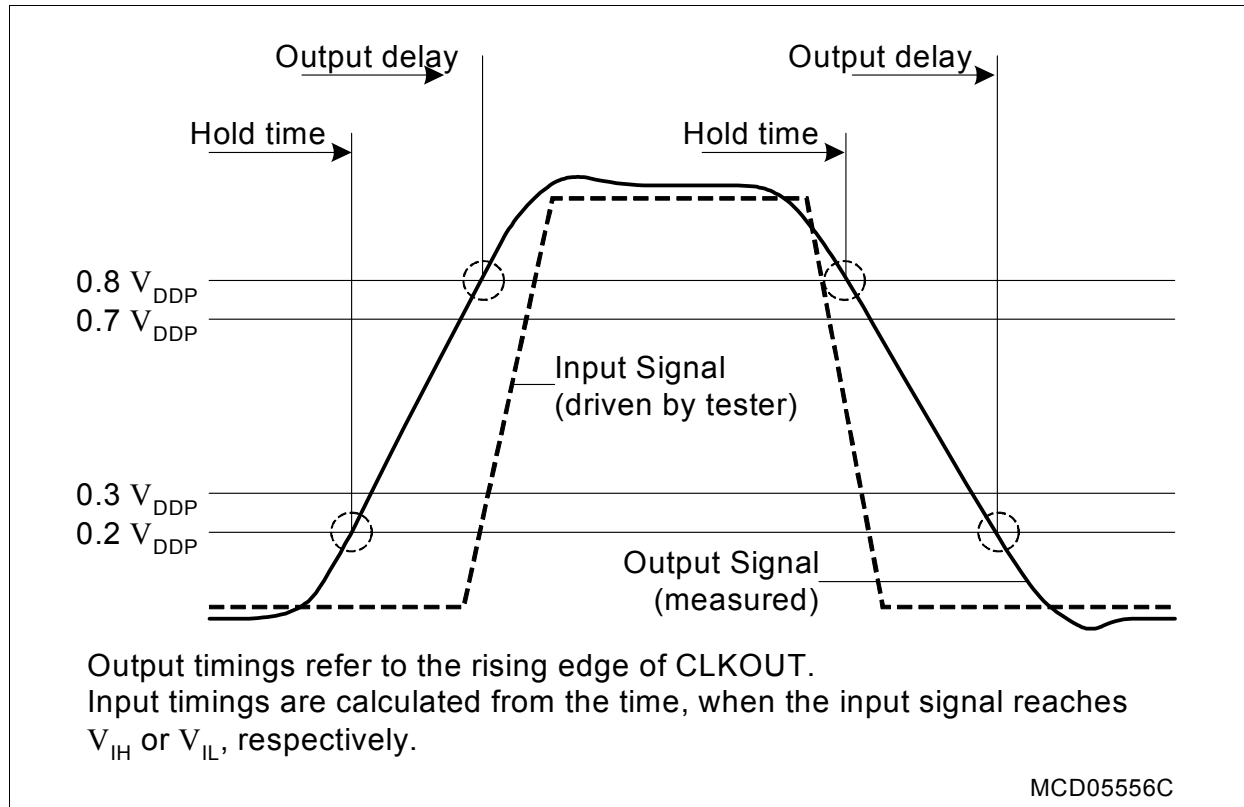


## 4.6 AC Parameters

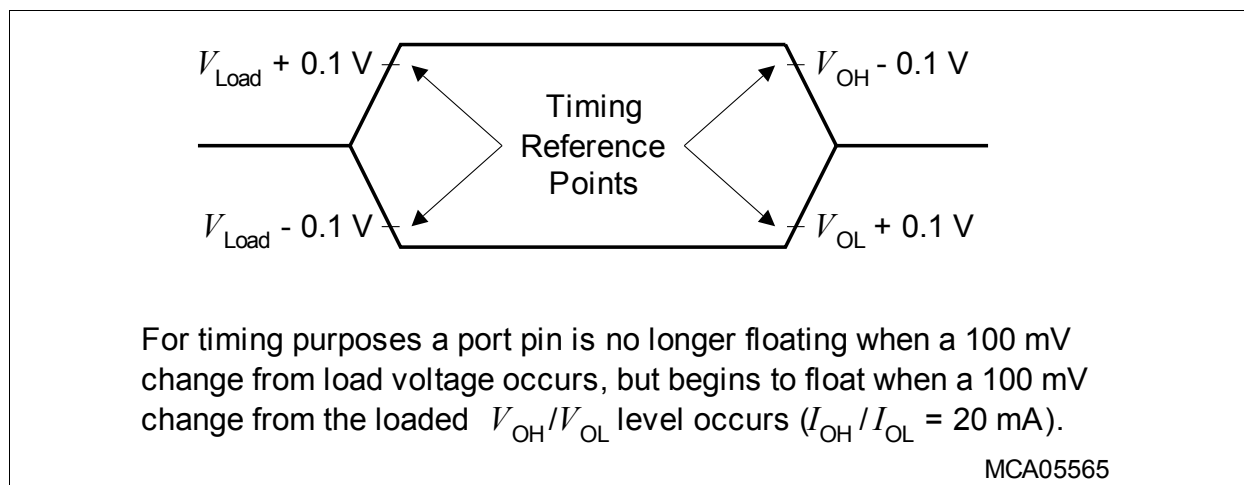
These parameters describe the dynamic behavior of the XE164.

### 4.6.1 Testing Waveforms

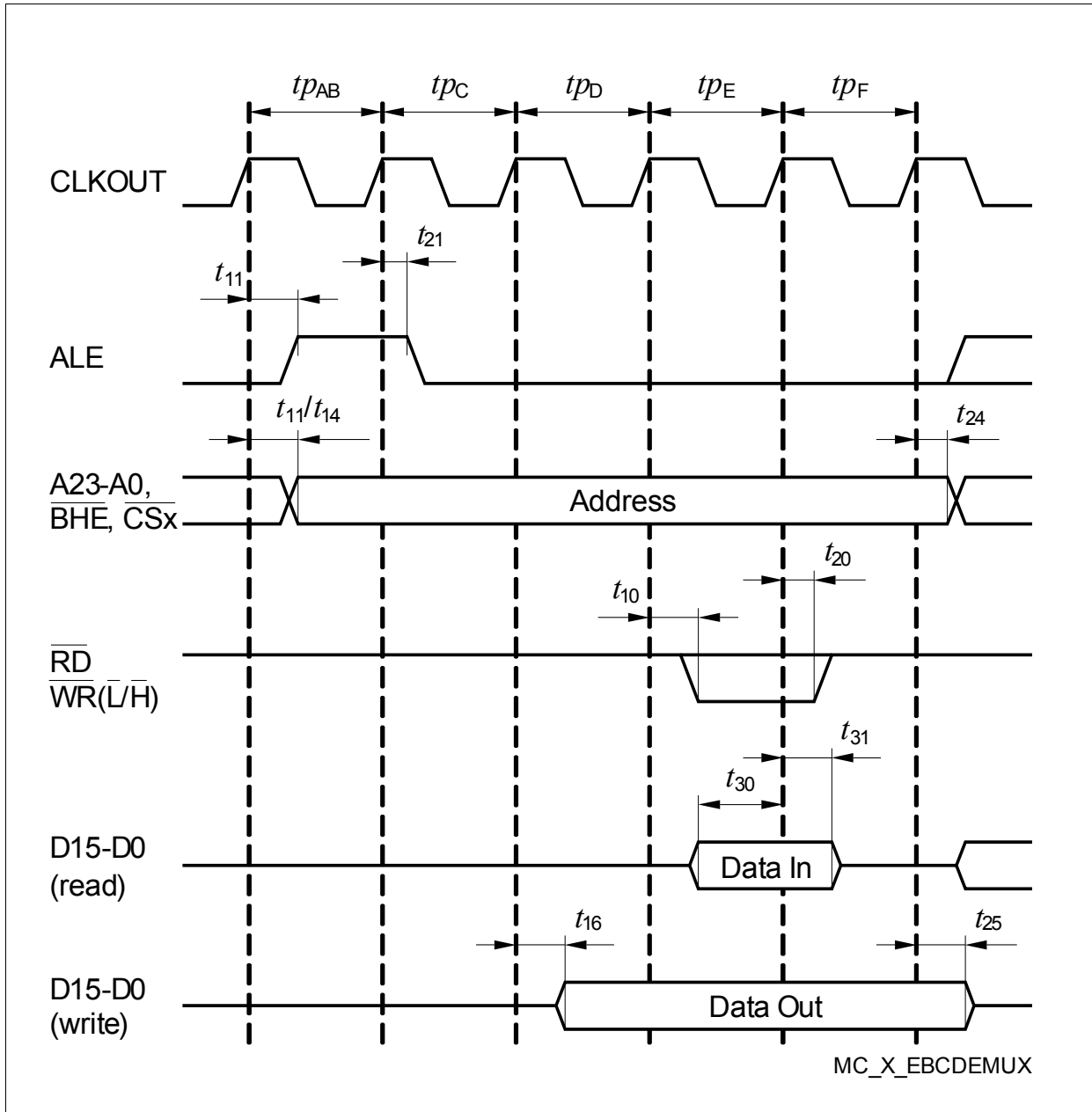
These values are used for characterization and production testing (except pin XTAL1).



**Figure 16 Input Output Waveforms**



**Figure 17 Floating Waveforms**



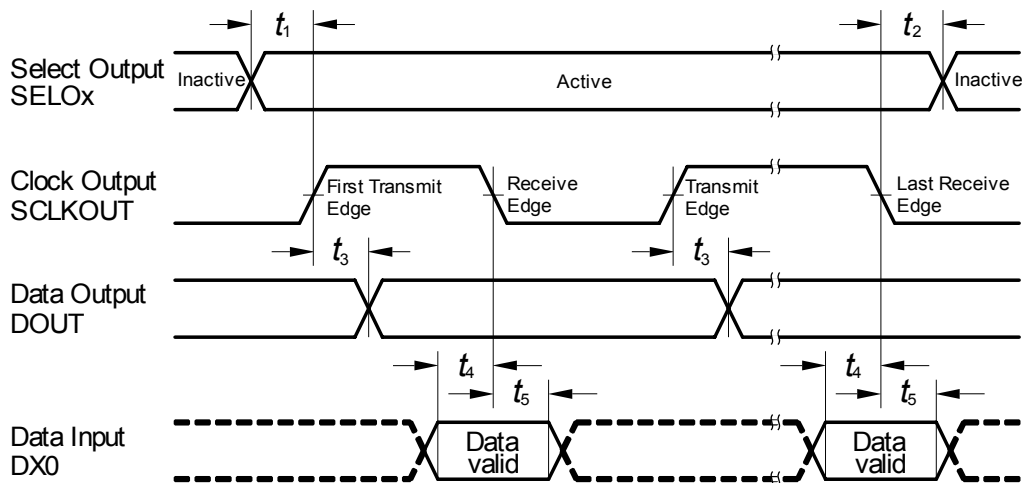
**Figure 23 Demultiplexed Bus Cycle**

**Table 32 SSC Master/Slave Mode Timing for Lower Voltage Range**  
(Operating Conditions apply),  $C_L = 50 \text{ pF}$

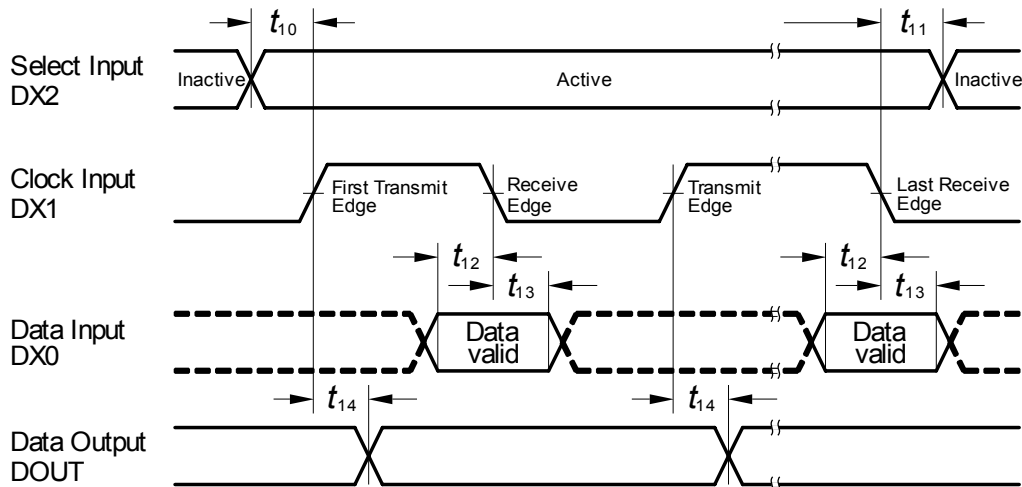
Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Master Mode Timing						
Slave select output SELO active to first SCLKOUT transmit edge	$t_1$ CC	0	—	1)	ns	2)
Slave select output SELO inactive after last SCLKOUT receive edge	$t_2$ CC	$0.5 \times t_{\text{BIT}}$	—	3)	ns	2)
Transmit data output valid time	$t_3$ CC	-13	—	16	ns	
Receive data input setup time to SCLKOUT receive edge	$t_4$ SR	48	—	—	ns	
Data input DX0 hold time from SCLKOUT receive edge	$t_5$ SR	-11	—	—	ns	
Slave Mode Timing						
Select input DX2 setup to first clock input DX1 transmit edge	$t_{10}$ SR	12	—	—	ns	4)
Select input DX2 hold after last clock input DX1 receive edge	$t_{11}$ SR	8	—	—	ns	4)
Data input DX0 setup time to clock input DX1 receive edge	$t_{12}$ SR	12	—	—	ns	4)
Data input DX0 hold time from clock input DX1 receive edge	$t_{13}$ SR	8	—	—	ns	4)
Data output DOUT valid time	$t_{14}$ CC	11	—	44	ns	4)

- 1) The maximum value further depends on the settings for the slave select output leading delay.
- 2)  $t_{\text{SYS}} = 1/f_{\text{SYS}} (= 12.5 \text{ ns @ } 80 \text{ MHz})$
- 3) The maximum value depends on the settings for the slave select output trailing delay and for the shift clock output delay.
- 4) These input timings are valid for asynchronous input signal handling of slave select input, shift clock input, and receive data input (bits DXnCR.DSEN = 0).

### Master Mode Timing



### Slave Mode Timing



Transmit Edge: with this clock edge transmit data is shifted to transmit data output

Receive Edge: with this clock edge receive data at receive data input is latched

Drawn for BRGH.SCLKCFG = 00<sub>B</sub>. Also valid for for SCLKCFG = 01<sub>B</sub> with inverted SCLKOUT signal

USIC\_SSC\_TMGX.VSD

**Figure 25 USIC - SSC Master/Slave Mode Timing**

*Note: This timing diagram shows a standard configuration where the slave select signal is low-active and the serial clock signal is not shifted and not inverted.*

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